HORIBA Scientific

Designed for use in the NIR, applications include NIR Raman, photoluminescence, emission, and absorbance spectroscopy.

Symphony II
Linear InGaAs Array
SII-1LS-512-25-17
SII-1LS-512-50-17
SII-1LS-1024-25-17

FLUORESCENCE

GRATINGS &
OEM SPECTROMETERS

OPTICAL COMPONENTS

PARTICLE CHARACTERIZATION

RAMAN

SPECTROSCOPIC ELLIPSOMETRY

SPR IMAGING

HORIBA Scientific's Symphony II InGaAs arrays are the ideal choice for demanding, low-light-level measurements in the near infrared (NIR) spectral region from 800-1700 nm. Offered in 512×1 (25×500 µm), 512×1 (50×500 µm), and 1024×1 (25×500 µm) pixel formats, these InGaAs detectors provide high resolution while maintaining full well capacity. Symphony II InGaAs arrays feature a 16-bit dynamic range, are liquid-nitrogen cooled to minimize dark noise, and use a mechanical shutter for subtraction of the dark background. Available with a 3-liter dewar for hours of uninterrupted data-collection. A plug-and-play USB 2.0 interface allows portability and easy setup on PC notebooks and desktop computers with 100% data integrity. Applications include near-IR Raman, photoluminescence measurements of semiconductors, SWCNTs, and nanowires. Detectors with sensitivity from 1 µm to 2.2 µm are also available.



Feature	Spectroscopy Benefits
Cryogenic Cooling	Cools the array to –103°C to minimize dark noise
Excellent Linearity	High accuracy of data over the full dynamic range
USB 2.0 Interface	Easy to use; connects to PC notebooks and desktops with 100% data integrity
High Sensitivity (HiS) and High Dynamic Range (HiD) modes	Software selection of acquisition mode to optimize detector for best signal-to- noise ratio
Auxiliary Signal Input	Unique ability to add measurements from single-channel detectors without additional electronics
HORIBA Scientific's SynerJY® Software	Complete control of a Symphony II CCD and HORIBA Scientific Spectrograph system with full analysis capabilities
LabVIEW VIs and SDK Available	Flexible software to integrate a Symphony II CCD into existing apparatus or as an OEM component JOBIN YVON Technology



ELEMENTAL ANALYSIS

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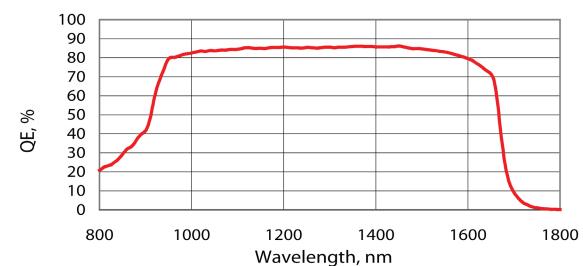
SPR IMAGING

Specifications*

512 × 1 1024 × 1		
(50×500) (25×500)		
800-1700 nm		
800-1600 nm		
–103°C		
Typical		
0.5–0.8 ke ⁻ rms		
5–8 ke ⁻ rms		
5 Me ⁻		
130 Me ⁻		
8 ke ⁻ /p/s		
± 5% ± 10%		
< ± 1%		
58 e⁻/count		
1545 e ⁻ /count		
16 bit		
Max of 5 dark or hot pixels Max of 10 dark or hot pixels		
130 Me ⁻ 8 ke ⁻ /p/s ± 5% < ± 1% 58 e ⁻ /count 1545 e ⁻ /count 16 bit Max of 5 dark or hot		

*Specifications subject to change without notice.

Quantum Efficiency at 25 °C



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